UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO. : 7.354.520 B2 APPLICATION NO.: 10/633523 DATED : April 8, 2008 Page 1 of 2

INVENTOR(S) : Takeshi Okada et al.

> It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

ON THE TITLE PAGE, AT ITEM (30), FOREIGN APPLICATION PRIORITY DATA

"Oct. 22" should read --Oct. 12--.

ON THE TITLE PAGE, AT ITEM (57), ABSTRACT

Line 12, "surrounded" should read --surrounded by the --.

COLUMN 6

Line 14, "surrounding" should read --surrounded--.

COLUMN 14

Line 45, "contains" should read --contain--.

COLUMN 20

Line 9, "L" should be deleted.

COLUMN 22

Line 27, "to plasma treatment" should read -- to a dry etching process--.

COLUMN 24

Line 16, "in" should read --um--.

Line 58, "133" should read -- 133°--.

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COLUMN 27

Line 53, "ANGEL" should read -- ANGLE --.

COLUMN 28

Line 8, "Kagaku)," should read -- Kagaku,--.

Signed and Sealed this

Second Day of December, 2008

JON W. DUDAS Director of the United States Patent and Trademark Office